

# NX30P6093

## High-voltage I<sup>2</sup>C controlled overvoltage protection load switch

Rev. 1.1 — 18 September 2018

Product data sheet

### 1. General description

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NX30P6093 is an 8 A I<sup>2</sup>C controlled overvoltage protection load switch for USB Type-C and PD applications. It includes undervoltage lockout, overvoltage lockout and overtemperature protection circuits, designed to automatically isolate the power switch terminals when a fault condition occurs. It features input pin impedance detection function, providing USB power supply pin status to system to avoid short circuit damage for the Type-C port power supply pin.

NX30P6093 has a default overvoltage protection threshold, and the OVLO threshold can be adjusted by both external resistor divider on ADJ pin and internal I<sup>2</sup>C register. A 22.5 ms debounce time is deployed every time before the device is switched ON, followed by a soft start to limit the inrush current.

Designed for operation from 2.8 V to 20.0 V, it can be used in USB Type-C and PD power control applications to offer essential protection and enhance system reliability.

NX30P6093 is offered in a small 20-bump 1.7 x 2.16 mm, 0.4 mm pitch WLCSP package.

### 2. Features and benefits

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- Wide supply voltage range for VIN from 2.8 V to 20.0 V
- System Power supply VDD from 3.0 V to 4.5 V
- I<sub>SW</sub> maximum 8 A continuous current
- 29 V tolerance on VIN pin
- 8.95 mΩ (typical) ultra-low ON resistance
- Adjustable VIN overvoltage protection by both external resistor and I<sup>2</sup>C
- Built in slew rate control for inrush current limit
- Integrated current source for VIN pin impedance detection
- Protection circuitry
  - ◆ Overtemperature protection
  - ◆ Overvoltage protection
  - ◆ Undervoltage lockout
- Surge protection:
  - ◆ IEC61000-4-5 exceeds ±100 V on VIN
- ESD protection
  - ◆ IEC61000-4-2 contact discharge exceeds 8 kV on VIN
  - ◆ IEC61000-4-2 air discharge exceeds 15 kV on VIN
  - ◆ HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 3 kV on all pins
  - ◆ MM Class B exceeds 100 V on all the pins



- Specified from -40 °C to +85 °C

### 3. Applications

- Smart and feature phones
- Tablets, eBooks
- Notebook

### 4. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
NX30P6093UK	-40 °C to +85 °C	WLCSP20	wafer level chip-scale package; 20 bumps; 1.70 mm x 2.16 mm x 0.525 mm body (backside coating included)	SOT1397-6

#### 4.1 Ordering options

Table 2. Ordering options

Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature
NX30P6093UK	NX30P6093UKAZ	WLCSP20	REEL 7" Q2/T3 *STANDARD MARK CHIPS, DP	4000	T <sub>amb</sub> = -40 °C to +85 °C

### 5. Marking

Table 3. Marking

Line	Marking	Description
A	X30P2	basic type name
B	mmmmmn	wafer lot code (mmmm) and wafer number (nn)
C	ZAYWW	manufacturing code: Z = foundry location A = assembly location Y = assembly year code WW = assembly week code
D	CCC-RRR	Die X-Y Coordinate

## 6. Functional diagram

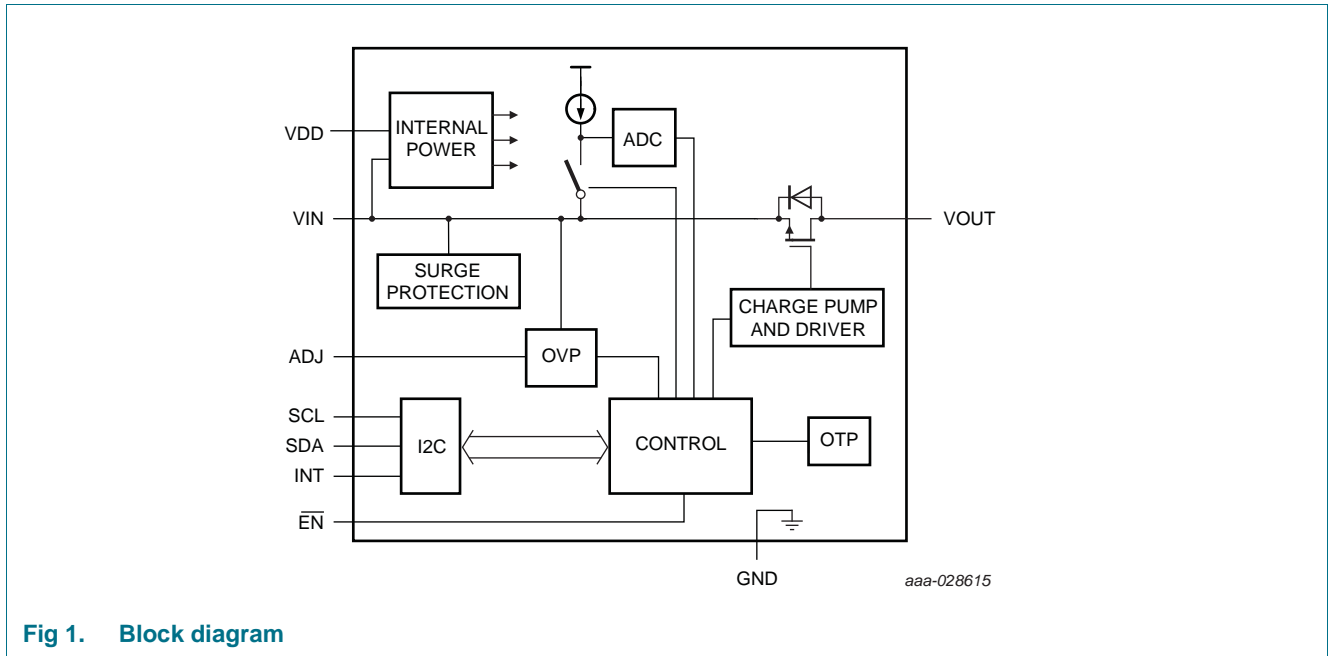


Fig 1. Block diagram

## 7. Pinning information

### 7.1 Pinning

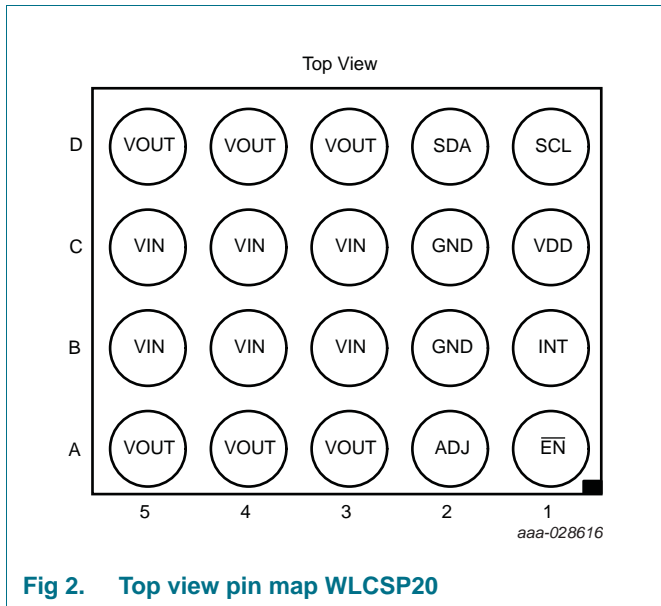


Fig 2. Top view pin map WLCSP20

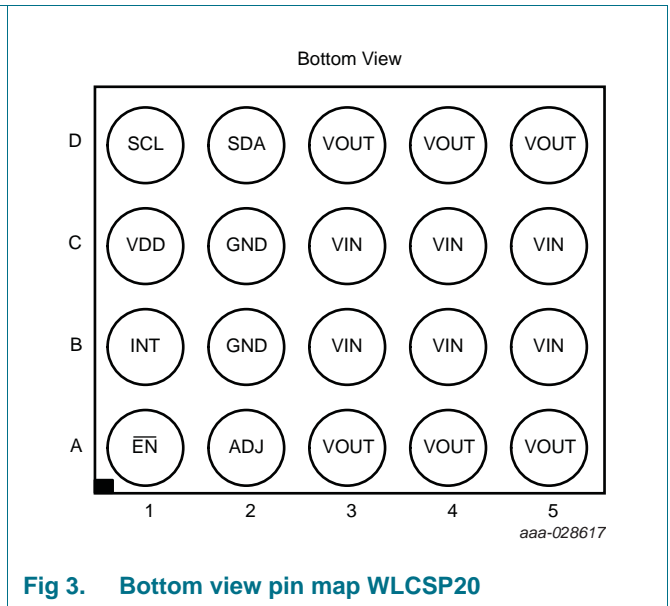


Fig 3. Bottom view pin map WLCSP20

## 7.2 Pin description

Table 4. Pin description

Symbol	Pin	Type	Description
VIN	B3, B4, B5 C3, C4, C5	Power I/O	Power Input pins, these pins should be connected together on PCB
VOUT	A3, A4, A5 D3, D4, D5	Power I/O	Power Input pins, these pins should be connected together on PCB
GND	B2, C2	Ground	Ground pin, these pin should be connected to system ground with good connection for surge protection discharge current
$\overline{\text{EN}}$	A1	Input	Enable pin, active low. When it is tied to high, the device enters low power standby mode and VOUT is disconnected from VIN. Internal pull down resistor integrated
$\overline{\text{INT}}$	B1	Output	I <sup>2</sup> C-bus interface interrupt to be connected to the I <sup>2</sup> C-bus master of the host processor
VDD	C1	Power	System Power supply for chip
SDA	D2	I/O	I <sup>2</sup> C-bus interface serial data to be connected to the I <sup>2</sup> C-bus master of the host processor
SCL	D1	Input	I <sup>2</sup> C-bus interface serial clock to be connected to the I <sup>2</sup> C-bus master of the host processor
ADJ	A2	Input	External OVLO adjust pin. Connect to OVLO resistor divider when select OVLO level by this pin. Connect to ground when it is not used, in this case OVLO determined internally

## 8. Functional description

NX30P6093 is an integrated device with two major functions: programmable overvoltage protection and VIN pin impedance detection. It protects the USB Type-C power supply pin and internal system by isolating high voltage when it exceeds OVLO threshold. The VIN pin impedance detection provides status monitoring for the system to avoid damage by short circuit of the USB Type-C power supply pin.

The impedance detection feature is activated when  $V_{IN} < V_{UVLO}$ ; in this case NX30P6093 supplied by system power VDD. When  $V_{IN} > V_{UVLO}$ , this feature is disabled automatically.

### 8.1 $\overline{EN}$ input

A HIGH on  $\overline{EN}$  disables the channel MOSFET, all protection circuits, and VIN impedance detection circuits, putting the device into a low power mode. A LOW on  $\overline{EN}$  enables the protection circuits and the MOSFET. There is an internal 1 MΩ pull-down resistor on the  $\overline{EN}$  pin to ensure the power switch conducting in a dead-battery situation. A 22.5 ms debounce time is deployed before device turn-on.

### 8.2 Slew rate tune

The slew rate control is integrated to avoid inrush current when the load switch turns on. In order to increase the design flexibility on system level, the slew rate can be tuned through I<sup>2</sup>C through register 0x0F as follows.

**Table 5. Slew rate tune setting by I<sup>2</sup>C register**

Register Value SRT[2:0]	Switch turn-on slew rate (TYP)
000	0.85 ms
001	0.9 ms
010	1 ms
011	1.35 ms (default)
100	1.8 ms
101	3 ms
110	5.5 ms
111	11 ms

### 8.3 Undervoltage lockout

When  $\overline{EN}$  is LOW and  $V_{IN} < V_{UVLO}$ , the Undervoltage Lockout (UVLO) circuit disables the power MOSFET. Once  $V_{IN}$  exceeds  $V_{UVLO}$ , if no other protection circuit is active and  $\overline{EN}$  is LOW, the MOSFET is turned on automatically regardless of the status of VOUT\_EN in register 0x01h. If  $\overline{EN}$  is HIGH, the MOSFET remains at off and at low power mode.

### 8.4 Overvoltage lockout

When  $\overline{EN}$  is LOW and  $V_{IN} > V_{OVLO}$ , the overvoltage lockout (OVLO) circuit disables the power MOSFET. The OV\_FLG in register 0x03h is set as “1” and an interrupt is issued to notify the host. Once  $V_{IN}$  drops below  $V_{OVLO}$  and no other protection circuit is active, the power MOSFET resumes operation.

The OVLO feature can be adjusted by both external resistor divider with ADJ pin and internal I<sup>2</sup>C register. The sequences are:

- When NX30P6093 is powering up, the initial OVLO threshold is set by ADJ pin. If there is a resistor divider connected to ADJ pin, the OVLO threshold is set by resistor divider value. If ADJ is floating or pull to ground, the OVLO threshold is set by default value in [Table 6](#).
- After power up, the OVLO threshold can be adjusted by system through the I<sup>2</sup>C register 0x05h according to the flow chart in [Figure 4](#).

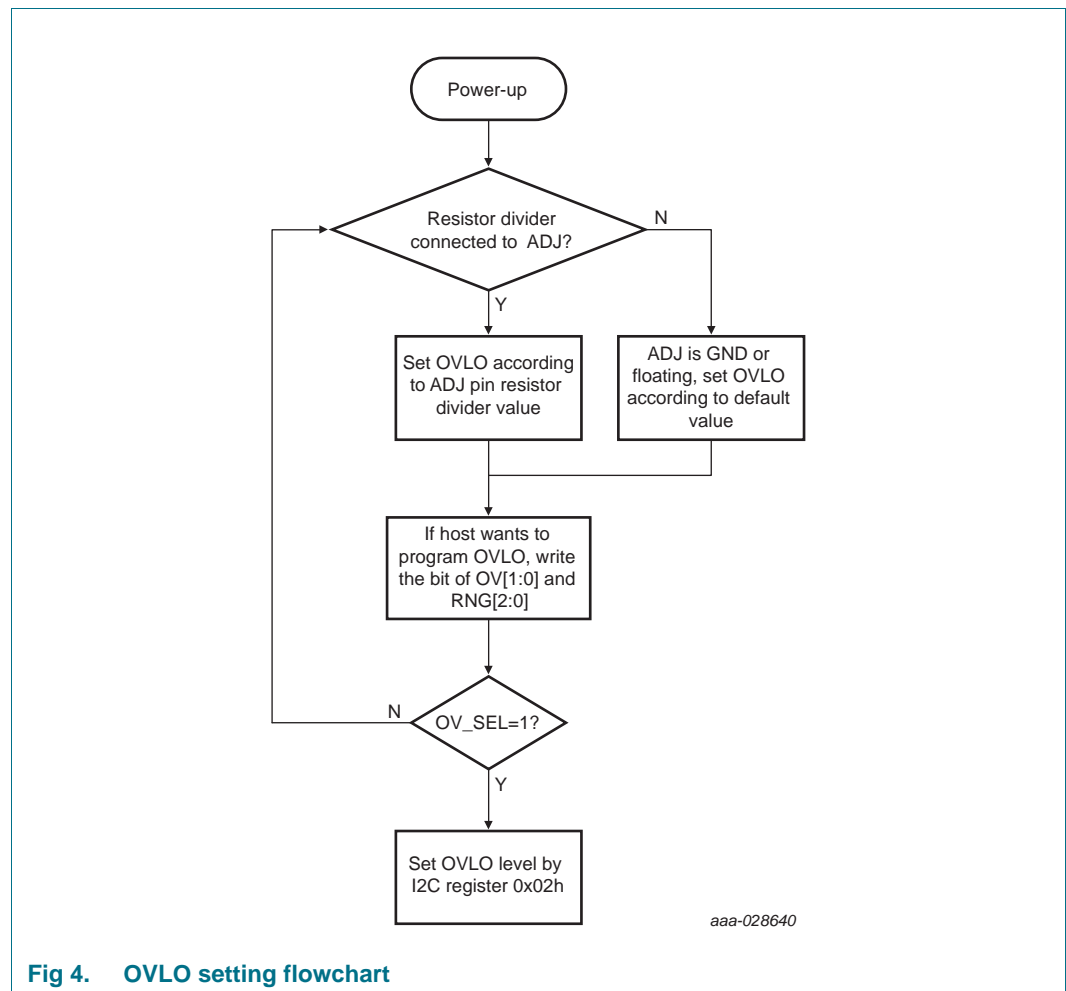


Fig 4. OVLO setting flowchart

When the overvoltage threshold is set by the ADJ pin with the connected resistor divider (see [Figure 7](#)), the overvoltage threshold is adjustable from 4 V to 23 V with below equation:

$$V_{ovlo} = V_{th(ovlo)} \times (R1 + R2) / (R2) \tag{1}$$

If the voltage on ADJ pin is below 0.1 V, the device uses internal default OVLO threshold.

When the overvoltage threshold is set by system through I<sup>2</sup>C-bus, it is set by bit0 and bit1 of register 0x05h. The OVLO thresholds are shown in [Table 6](#).

**Table 6. OVLO threshold setting by I<sup>2</sup>C register**

Register Value OV[1:0]	OVLO Threshold
00	6.8 V (default)
01	11.5 V
10	17 V
11	23 V

In addition, NX30P6093 provides two additional OVLO thresholds by bit0, bit1 of register 0x0Eh. The additional OVLO thresholds are shown in [Table 7](#).

**Table 7. Additional OVLO threshold setting by I<sup>2</sup>C register**

Register Value AOVP[1:0]	OVLO Threshold
00	OVLO set by <a href="#">Table 6</a> .
01	OVLO set by <a href="#">Table 6</a> .
10	10 V
11	14 V

Furthermore when the OVLO threshold is set by I<sup>2</sup>C register, it can be fine tuned by bit6-bit4 of register 0x05h. The fine tune values are shown in [Table 8](#).

**Table 8. OVLO threshold fine tune setting by I<sup>2</sup>C register**

Register Value RNG[2:0]	OVLO Threshold Fine Tune value
000	-600 mV
001	-400 mV
010	-200 mV
011	0 mV (default)
100	+200 mV
101	+400 mV
110	+600 mV
111	+800 mV

## 8.5 Overtemperature protection

When  $\overline{\text{EN}}$  is LOW and the device temperature exceeds 140 °C, the Overtemperature Protection (OTP) circuit disables the power MOSFET and an interrupt is issued by set OT\_FLG as "1" in register 0x03h. Once the device temperature decreases below 120 °C and no other protection circuit is active, the state of the N-channel MOSFET is controlled by the  $\overline{\text{EN}}$  pin again.

## 8.6 Short circuit protection

NX30P6093 has short circuit protection; after the MOSFET is fully turned on and when the current through it exceeds 12 A, it turns the MOSFET off to protect the device and system. An interrupt is issued when short circuit protection is triggered by set OC\_FLG as "1" in register 0x03h. Once the short circuit condition is removed and no other protection circuit is active, the state of the N-channel MOSFET is controlled by the  $\overline{\text{EN}}$  pin again.

## 8.7 VIN Impedance detection

A VIN impedance detection function is integrated in NX30P6093. When  $\overline{EN}$  is LOW and  $VIN < V_{UVLO}$ , NX30P6093 enters VIN detection sleep mode. The host can start the VIN impedance detection according to the following sequences. First, the host can write DETC\_EN bit to "1" through I<sup>2</sup>C, which activates NX30P6093 to VIN detection standby mode. In this mode, NX30P6093 turns on internal function circuits and is ready to run detection. After a wake up time  $t_{WAKEUP}$ , the host can configure  $t_{DET}$ ,  $t_{DUTY}$  and Tag voltage by writing to register 0x07h and 0x09h through I<sup>2</sup>C. When  $I_{SOURCE}$  is changed from default 0  $\mu$ A to any of valid current values in [Table 8](#), NX30P6093 starts the VIN detection according to configured  $t_{DET}$  and  $t_{DUTY}$  time.

In any of VIN detection modes, while VIN is plugged and the voltage on VIN pin exceeds  $V_{UVLO}$ , NX30P6093 exits from VIN detection modes to OVP operation modes immediately.

When the VIN detection ADC result is valid after  $t_{DET}$  timer out, the TMR\_OUT\_STS is set to "1" and an interrupt issued. The host can read the VIN detection voltage at register 0x08h by then. Meanwhile, NX30P6093 can compare the detection result versus the host set VIN TAG voltage in register 0x09h. When the detected voltage is larger than the set VIN TAG voltage, the OVER\_TAG\_STS is set to "1" in register 0x02h and an interrupt is issued.

The VIN pin impedance can be the following two different cases according to the application in system:

- When there is no resistor divider connected to VIN and ADJ pins, the measured impedance (RM) is VIN impedance (RP).
- When an OVLO resistor divider connected to VIN and ADJ pins, the measured impedance (RM) is VIN impedance (RP) parallels with external OVLO resistor divider R1+R2, (see [Figure 7](#)).

[Table 9](#) shows the current source values, which can be programmed by bit 3 to bit 0 of register 0x06h. Please note there are several internal circuits connected to VIN pin, e.g., Surge protection and UVLO resistor ladder. That generates a leakage current according to a different VIN voltage specified in [Table 28](#) as  $I_{DET\_LEAKAGE}$ . This leakage should be excluded in the resistor calculation of VIN impedance detection.

**Table 9. Current source set by I<sup>2</sup>C register**

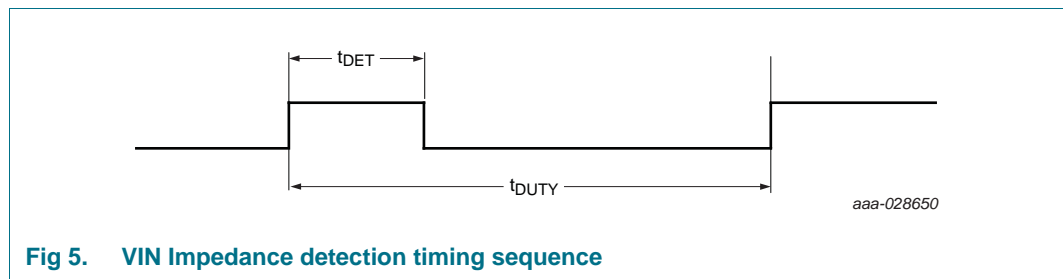
Register value ISRC[3:0]	Current source value
0000	0 $\mu$ A (default)
0001	1 $\mu$ A
0010	2 $\mu$ A
0011	3 $\mu$ A
0100	4 $\mu$ A
0101	5 $\mu$ A
0110	10 $\mu$ A
0111	20 $\mu$ A
1000	50 $\mu$ A
1001	100 $\mu$ A
1010	200 $\mu$ A



**Table 9.** Current source set by I<sup>2</sup>C register ...continued

Register value ISRC[3:0]	Current source value
1011	500 $\mu$ A
1100	1000 $\mu$ A
1101	2000 $\mu$ A
1110	5000 $\mu$ A
1111	10000 $\mu$ A

NX30P6093 turns on the I<sub>source</sub> according to the following system required timing sequence.



**Fig 5.** VIN Impedance detection timing sequence

The current source turn-on pulse width t<sub>DET</sub> is set by bit7 - bit4 of register 0x07h as follows.

**Table 10.** Current source turn-on pulse width set by I<sup>2</sup>C register

Register Value TDET[3:0]	I <sub>source</sub> turn-on Pulse Width (t <sub>DET</sub> )
0000	200 $\mu$ s (default)
0001	400 $\mu$ s
0010	1000 $\mu$ s
0011	2000 $\mu$ s
0100	4000 $\mu$ s
0101	10000 $\mu$ s
0110	20000 $\mu$ s
0111	40000 $\mu$ s
1000	100000 $\mu$ s
1001	200000 $\mu$ s
1010	400000 $\mu$ s
1011	1000000 $\mu$ s
1100	2000000 $\mu$ s
1101	4000000 $\mu$ s
1110	10000000 $\mu$ s
1111	Always on

The detection duty cycle is set by bit3 to bit0 of register 0x07h according to the following table.

Table 11. Detection duty cycle setting by I<sup>2</sup>C register

Register Value DUTY[3:0]	Detection duty cycle (t <sub>DUTY</sub> )
0000	single pulse (default)
0001	10 ms
0010	20 ms
0011	50 ms
0100	100 ms
0101	200 ms
0110	500 ms
0111	1000 ms
1000	2000 ms
1001	3000 ms
1010	6000 ms
1011	12000 ms
1100	30000 ms
1101	60000 ms
1110	120000 ms
1111	300000 ms

### 8.8 Interrupt

NX30P6093 has two types of interrupt. One is the interrupt generated by Flag register 0x03h, which includes the alarms for overvoltage, overtemperature and short circuit. The second type of interrupt is generated by Status register 0x02h. The following is a detailed description of the two interrupts.

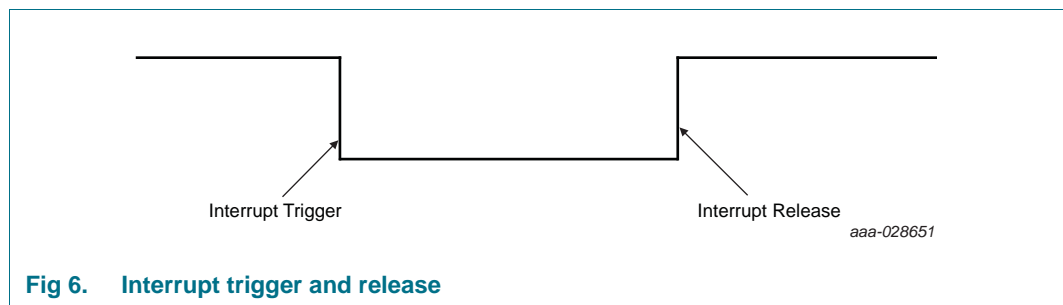


Fig 6. Interrupt trigger and release

- The interrupt trigger is by all 3 bits of Flag register (0x03h) and 4 bits of Status register (0x02h). When one of them changes from “0” to “1”, the interrupt is triggered. An event will be latched and only the first occurrence triggers an interrupt (if not masked). Reoccurring events will not trigger an additional interrupt.
- The interrupt release of the Flag register is by read on clear, t<sub>DET</sub> timer start, the interrupt status over 1000 ms or NX30P6093 disabled by  $\overline{EN}$ . For OV\_FLG and OT\_FLG interrupt, if it is not read by host and the fault condition is back to normal in 1000ms, the INT will be released. The bit values of register 0x03h are cleared only by host read or VIN dropping below UVLO.

- The interrupt release of Status register is by read on clear,  $t_{DET}$  timer start, the interrupt status over 1000ms or NX30P6093 disabled by  $\overline{EN}$ . The 4 bit values are the real status of the circuit status and will not be cleared when the host reads them after an interrupt.

## 8.9 I<sup>2</sup>C-bus interface

NX30P6093 implements an I<sup>2</sup>C-bus slave interface which interfaces with the host system. The host processor can issue commands, monitor status and receive response through this bus. A detailed description of the I<sup>2</sup>C-bus specification, with applications, is given in *UM10204, "I<sup>2</sup>C-bus specification and user manual"*. NX30P6093 supports I<sup>2</sup>C-bus data transfers in both Standard-mode (100 kbit/s), Fast-mode (400 kbit/s) and Fast-mode (2 Mbit/s).

As an exception to the I<sup>2</sup>C-bus specification, the NX30P6093 does not support the I<sup>2</sup>C 'General Call' address (and therefore does not issue an Acknowledge), clock stretching, Software Reset command, nor 10-bit address. The various registers, address offsets and bit definitions are shown in [Table 12](#).

The I<sup>2</sup>C address at Power-On Reset is as follows:

- Write address: 0x6C
- Read address: 0x6D

Table 12. NX30P6093 Register map

Addr	Name	Type	Reset Value	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	
0x00h	Device ID Register	R	-	Vendor ID					Version ID			
0x01h	Enable Register	R/W	00h	VOUT_EN	DETC_EN	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	
0x02h	Status Register	R	00h	PWRON_STS	OVER_TAG_STS	TMR_OUT_STS	SWON_STS	Reserved	Reserved	Reserved	Reserved	
0x03h	Flag	C/R	00h	Reserved	Reserved	Reserved	Reserved	Reserved	OV_FLG	OC_FLG	OT_FLG	
0x04h	Interrupt Mask	R/W	F7h	PWRON_STS	OVER_TAG_STS	TMR_OUT_STS	SWON_STS	Reserved	OV_FLG	OC_FLG	OT_FLG	
0x05h	OVLO Trigger level	R/W	30h	Reserved	RNG2	RNG1	RNG0	OV_SEL	Reserved	OV1	OV0	
0x06h	I <sub>source</sub> to VIN	R/W	00h	Reserved	Reserved	Reserved	Reserved	ISRC3	ISRC2	ISRC1	ISRC0	
0x07h	I <sub>source</sub> working time	R/W	00h	TDET3	TDET2	TDET1	TDET0	DUTY3	DUTY2	DUTY1	DUTY0	
0x08h	Voltage to VIN	R	00h	VIN7	VIN6	VIN5	VIN4	VIN3	VIN2	VIN1	VIN0	
0x09h	Set Tag on VIN	R/W	FFh	TVIN7	TVIN6	TVIN5	TVIN4	TVIN3	TVIN2	TVIN1	TVIN0	
0x0Ah	Reserved	R/W	00h	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	
0x0Bh	Reserved	R/W	00h	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	
0x0Ch	Reserved	R/W	00h	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	
0x0Dh	Reserved	R/W	00h	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	
0x0Eh	Additional OVP	R/W	00h	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	AOVP1	AOVP0	
0x0Fh	Slew rate Tune	R/W	03h	Reserved	Reserved	Reserved	Reserved	Reserved	SRT2	SRT1	SRT0	

### 8.9.1 Device ID Register (Address 0x00h)

Table 13. Device ID Register

Bit	Name	Type	Reset Value	Description
7:3	Vendor ID	R	10011	NXP Vendor ID 00011
2:0	Version ID	R	010	Device revision number 010

### 8.9.2 Enable Register (Address 0x01h)

Table 14. Enable Register

Bit	Name	Type	Reset Value	Description
7	VOUT_EN	R/W	0h	0h = Main switch MOSFET turned on 1h = Main switch MOSFET turned off
6	DETC_EN	R/W	0h	0h = ISOURCE VIN impedance detection turn off 1h = ISOURCE VIN impedance detection turn on
5:0	Reserved	R/W	0h	0h = default

### 8.9.3 Status Register (Address 0x02h)

Table 15. Status Register

Bit	Name	Type	Reset Value	Description
7	PWRON_STS	R	0h	0h = VIN voltage less than $V_{UVLO}$ 1h = VIN voltage larger than $V_{UVLO}$ . An interrupt will be issued, please refer to <a href="#">Section 8.7</a> for the details
6	OVER_TAG_STS	R	0h	0h = VIN detected voltage less than Tag voltage 1h = VIN detected voltage larger than Tag voltage. An interrupt will be issued, please refer to <a href="#">Section 8.7</a> for the details
5	TMR_OUT_STS	R	0h	0h = $t_{DET}$ timer is not out 1h = $t_{DET}$ timer out. An interrupt will be issued, please refer to <a href="#">Section 8.7</a> for the details
4	SWON_STS	R	0h	0h = The main switch is turned off 1h = The main switch is turned on. An interrupt will be issued, please refer to <a href="#">Section 8.7</a> for the details
3:0	Reserved	R	0h	0h = default

### 8.9.4 Flag Register (Address 0x03h)

This is the interrupt register, when one of the FLAGS is “1”, the INT pin will be pulled LOW. Please refer to [Section 8.8](#).

**Table 16. FLAG Register**

Bit	Name	Type	Reset Value	Description
7:3	Reserved	C/R	0h	0h = Default
2	OV_FLG	C/R	0h	overvoltage protection flag When overvoltage protection triggered, set this bit as "1"
1	OC_FLG	C/R	0h	Short circuit protection flag When short circuit protection triggered, set this bit as "1"
0	OT_FLG	C/R	0h	Overtemperature protection flag When Overtemperature protection triggered, set this bit as "1"

**8.9.5 Interrupt Mask Register (Address 0x04h)**

This is the register to enable masking of the interrupts of both Flag Register and Status Register.

**Table 17. Interrupt Mask Register**

Bit	Name	Type	Reset Value	Description
7	PWRON_STS	R/W	1h	0h = mask OVER_TAG_STS interrupt 1h = Do not mask OVER_TAG_STS interrupt
6	OVER_TAG_STS	R/W	1h	0h = mask OVER_TAG_STS interrupt 1h = Do not mask OVER_TAG_STS interrupt
5	TMR_OUT_STS	R/W	1h	0h = mask TMR_OUT_STS interrupt 1h = Do not mask TMR_OUT_STS interrupt
4	SWON_STS	R/W	1h	0h = mask OVER_TAG_STS interrupt 1h = Do not mask OVER_TAG_STS interrupt
3	Reserved	R/W	0h	0h = Default
2	OV_FLG	R/W	1h	0h = mask OV_FLG interrupt 1h = Do not mask OV_FLG interrupt
1	OC_FLG	R/W	1h	0h = mask OC_FLG interrupt 1h = Do not mask OC_FLG interrupt
0	OT_FLG	R/W	1h	0h = mask OT_FLG interrupt 1h = Do not mask OT_FLG interrupt

**8.9.6 OVLO trig level Register (Address 0x05h)**

This is the register to set OVLO trig level and also another 2 bits for enable signal.

Table 18. OVLO trig level Register

Bit	Name	Type	Reset Value	Description
7	Reserved	R/W	0h	0h = Default
6:4	RNG[2:0]	R/W	03h	OVLO fine tune bits, please refer to <a href="#">Section 8.4</a>
3	OV_SEL	R/W	0h	0h= OVLO level adjusted by ADJ pin 1h=OVLO level adjusted by I <sup>2</sup> C register bit
2	Reserved	R/W	0h	0h = Default
1:0	OV[1:0]	R/W	0h	OVLO threshold set bits, please refer to <a href="#">Section 8.4</a>

### 8.9.7 I<sub>source</sub> to VIN Register (Address 0x06h)

This is the register to set I<sub>source</sub> value for VIN impedance detection; please refer to [Section 8.7](#).

Table 19. I<sub>source</sub> to VIN register

Bit	Name	Type	Reset Value	Description
7:4	Reserved	R/W	0h	0h = Default
3:0	ISRC[3:0]	R/W	0h	I <sub>source</sub> current value setting bits

### 8.9.8 I<sub>source</sub> timing Register (Address 0x07h)

This is the register to set I<sub>source</sub> timing for VIN impedance detection; please refer to [Section 8.7](#).

Table 20. I<sub>source</sub> timing Register

Bit	Name	Type	Reset Value	Description
7:4	TDET[3:0]	R/W	0h	I <sub>source</sub> current pulse width setting bits
3:0	DUTY[3:0]	R/W	0h	VIN Impedance detection duty cycle setting bits

### 8.9.9 Voltage on VIN Register (Address 0x08h)

This is the register to store the VIN voltage detection results from ADC; please refer to [Section 8.7](#).

Table 21. Voltage on VIN Register

Bit	Name	Type	Reset Value	Description
7:0	VIN[7:0]	R	0h	VIN voltage detection results. The detected VIN voltage can be calculated as: $V_{DET} = 2.7 \times \frac{VIN[7:0]}{256}$ Where VIN[7:0] is the decimal value of this register

**8.9.10 Set tag on VIN Register (Address 0x09h)**

This is the register to set the tag of VIN voltage in VIN impedance detection, please refer to [Section 8.7](#).

**Table 22. Set tag on VIN Register**

Bit	Name	Type	Reset Value	Description
7:0	TVIN[7:0]	R/W	FFh	Set tag of VIN voltage bits. The TVIN [7:0] can be calculated as:  $TVIV = \frac{V_{TAG}}{2.7}$ Where TVIN is decimal data and should be transferred to binary to TVIN[7:0]

**8.9.11 Additional OVP Register (Address 0x0Eh)**

This is the register to set additional OVLO trip level, please refer to [Section 8.4](#) for the details.

**Table 23. Additional OVP Register**

Bit	Name	Type	Reset Value	Description
7:2	Reserved	R/W	00h	00h = Default
1:0	AOVP[1:0]	R/W	00h	Set additional OVLO trip level

**8.9.12 Slew rate tune Register (Address 0x0Fh)**

This is the register to set the load switch slew rate. please refer to [Section 8.2](#) for the details.

**Table 24. Additional OVP Register**

Bit	Name	Type	Reset Value	Description
7:3	Reserved	R/W	00h	00h = Default
2:0	SRT[2:0]	R/W	03h	Set slew rate tune

**9. Application diagram**

The NX30P6093 is typically used on a USB port charging path in a portable, battery operated device. The I<sup>2</sup>C signals require an external pull-up resistor which should be connected to a supply voltage matching the logic input pin supply level that it is connected to.

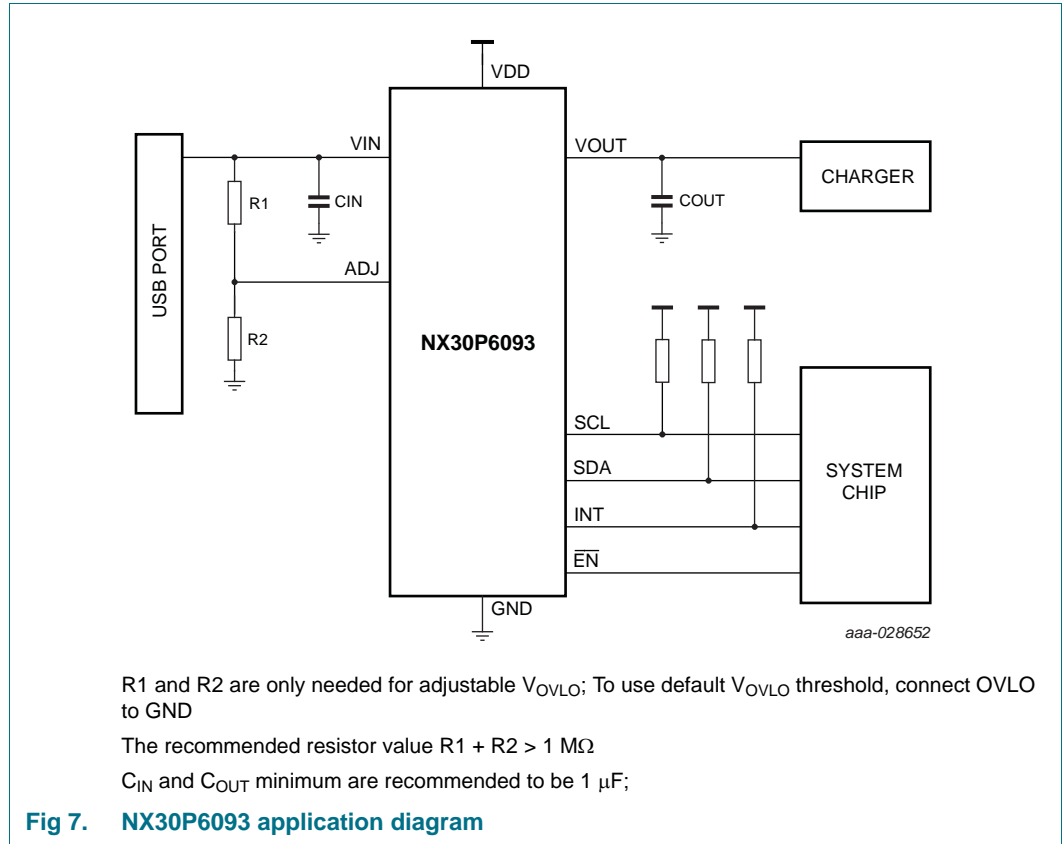
When the default internal OVLO threshold is used, the ADJ pin shall be shorted to GND. While OVLO threshold is adjusted by ADJ pin, a resistor divider shall be connected.

In order to have better VIN pin impedance detection range, it is recommended that the total resistance of R1 and R2 are larger than 1 MΩ.



For the best performance, it is recommended to keep input and output trace short and capacitors as close to the device as possible. Regarding the thermal performance, it is recommended to increase the PCB area around VIN and VOUT pins.

The NX30P6093 does not support OTG mode.



## 10. Limiting values

**Table 25. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>I</sub>	input voltage	VIN	[1] -2	+29	V
		VDD	-0.3	+7.0	V
		ADJ	-0.3	VIN	V
		$\overline{\text{EN}}$	[2] -0.3	+7.0	V
		SCL, SDA	-0.3	+7.0	V
V <sub>O</sub>	output voltage	VOUT	-0.3	+22	V
		$\overline{\text{EN}}$	-0.3	+7.0	V
I <sub>IK</sub>	input clamping current	$\overline{\text{EN}}$ : V <sub>I</sub> < -0.5 V	-50	-	mA
I <sub>SK</sub>	switch clamping current	VIN; VOUT; V <sub>I</sub> < -0.5 V	-50	-	mA
I <sub>SW</sub>	continuous switch current	T <sub>amb</sub> = 85 °C	-	8	A
	peak switch current	100 μs pulse, 2 % duty cycle	-	10	A
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation		[3] -	1.7	W

[1] The -2 V limiting value is 200 ms non-repetitive pulse

[2] The minimum input voltage rating may be exceeded if the input current rating is observed.

[3] The (absolute) maximum power dissipation depends on the junction temperature T<sub>j</sub>. Higher power dissipation is allowed in conjunction with lower ambient temperatures. The conditions to determine the specified values are T<sub>amb</sub> = 25 °C and the use of a 4 layer PCB.

## 11. Recommended operating conditions

**Table 26. Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>I</sub>	input voltage	VIN	2.8	20	V
		$\overline{\text{EN}}$	0	5.5	V
		VDD	3.0	4.5	V
V <sub>O</sub>	output voltage	$\overline{\text{INT}}$	0	5.5	V
T <sub>j(max)</sub>	maximum junction temperature		-40	+125	°C
T <sub>amb</sub>	ambient temperature		-40	+85	°C

## 12. Thermal characteristics

Table 27. Thermal characteristics

Symbol	Parameter	Conditions		Typ	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		[1][2]	58.6	K/W

- [1] The overall  $R_{th(j-a)}$  can vary depending on the board layout. To minimize the effective  $R_{th(j-a)}$ , all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Try not to use any solder-stop varnish under the chip.
- [2] This  $R_{th(j-a)}$  is calculated based on JEDEX2S2P board. The actual  $R_{th(j-a)}$  value may vary in applications using different layer stacks and layouts.

### 13. Static characteristics

**Table 28. Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			T <sub>amb</sub> = -40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
V <sub>IH</sub>	HIGH-level input voltage	$\overline{EN}$ pin; V <sub>I(VIN)</sub> = 2.8 V to 20 V	1.2	-	-	1.2	-	V
V <sub>IL</sub>	LOW-level input voltage	$\overline{EN}$ pin; V <sub>I(VIN)</sub> = 2.8 V to 20 V	-	-	0.4	-	0.4	V
I <sub>EN</sub>	Input leakage current	$\overline{EN}$ pin; V <sub>I(<math>\overline{EN}</math>)</sub> = 0 V	-	0.1	-	-1	1	μA
C <sub>I</sub>	input capacitance	$\overline{EN}$ pin; V <sub>I(VIN)</sub> = 5 V	-	5	-	-	-	pF
R <sub>pd</sub>	pull-down resistance	$\overline{EN}$ pin	-	1	-	-	-	MΩ
I <sub>q</sub>	VIN quiescent current	$\overline{EN}$ = 0 V; V <sub>I(VIN)</sub> = 5.0 V; I <sub>O</sub> = 0 A	-	150	-	-	200	μA
		$\overline{EN}$ = 5.0 V; V <sub>I(VIN)</sub> = 5.0 V; I <sub>O</sub> = 0 A	-	1	-	-	3	μA
I <sub>q_SLEEP</sub>	VDD Sleep mode current	$\overline{EN}$ = 0 V; V <sub>I(VIN)</sub> < V <sub>UVLO</sub> ; VDD=3.0 V; DETC_EN=0	-	10	-	-	18	μA
I <sub>DET_LEAKAGE</sub>	VIN Pin leakage in detection mode	$\overline{EN}$ = 0 V; V <sub>I(VIN)</sub> = 1 V; DETC_EN=1	-	0.2	-	-	0.5	μA
I <sub>S(OFF)</sub>	VOUT OFF-state leakage current	$\overline{EN}$ = 5.0 V; V <sub>I(VIN)</sub> = 5.0 V; VOUT = 0 V	-	0.5	-	-	2	μA
V <sub>UVLO</sub>	undervoltage lockout release voltage	VIN Rising; $\overline{EN}$ = 0 V	-	2.65	-	2.5	2.8	V
V <sub>hys(UVLO)</sub>	undervoltage lockout hysteresis voltage	VIN Falling	-	100	-	-	-	mV
I <sub>OVLO</sub>	ADJ pin input leakage current	VIN = 5 V, V <sub>ADJ</sub> = 3 V; apply after power up	-	3	-	-	6	μA
		VIN = 5 V, V <sub>ADJ</sub> = 3 V; apply before power up	-	10	-	-	100	nA
V <sub>OVLO</sub>	Default overvoltage lockout voltage	VIN Rising; $\overline{EN}$ = 0 V; ADJ short to GND	-	6.8	-	6.6	7.0	V
V <sub>hys(OVLO)</sub>	overvoltage lockout hysteresis voltage	VIN Falling; $\overline{EN}$ = 0 V; ADJ short to GND	-	2	-	1.3	2.7	%
V <sub>th(OVLO)</sub>	external OVLO set threshold voltage	V <sub>I(VIN)</sub> = 2.8 V to 20 V; $\overline{EN}$ = 0 V	-	1.204	-	1.175	1.224	V

#### I<sup>2</sup>C-bus Interface Specifications

V <sub>IH</sub>	HIGH-level input voltage	SCL, SDA; VDD = 3.0 V to 4.5 V	1.2	-	-	1.2	-	V
V <sub>IL</sub>	LOW-level input voltage	SCL, SDA; VDD = 3.0 V to 4.5 V	-	-	0.4	-	0.4	V
V <sub>OL</sub>	LOW-level output voltage	$\overline{INT}$ pin; VDD = 3.0 V to 4.5 V; I <sub>load</sub> = 1 mA	-	-	0.3	-	0.3	V
f <sub>CLK_I2C</sub>	I <sup>2</sup> C-bus clock frequency		0	-	1	0	1	MHz

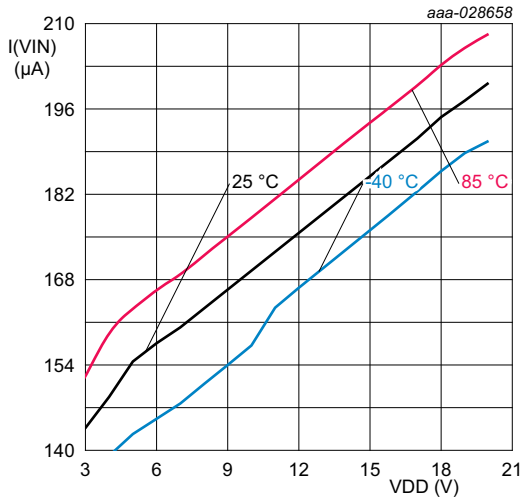
#### I<sub>SOURCE</sub> ADC Specifications

**Table 28. Static characteristics ...continued**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

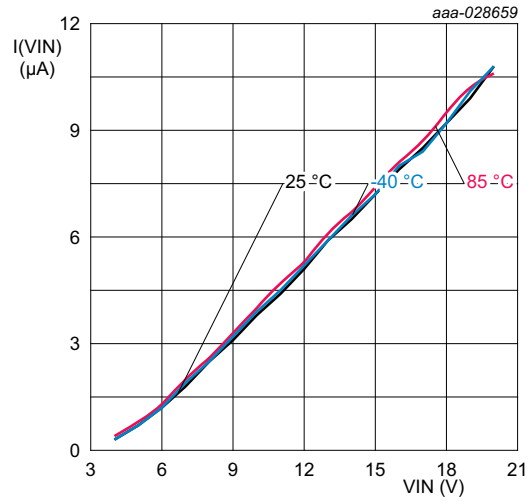
Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			T <sub>amb</sub> = -40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
I <sub>SOURCE_AC</sub> C	Current source accuracy	VDD = 3.0 V to 4.5 V	-	-	5	-	5	%
V <sub>ADC</sub>	ADC input voltage range	VDD = 3.0 V to 4.5 V	0		2.5	0	2.5	V
V <sub>ADC</sub>	ADC reference voltage	VDD = 3.0 V to 4.5 V	-	2.7	-	2.64	2.76	V
Resolution	ADC bits	VDD = 3.0 V to 4.5 V	-	8	-	-	-	bit
<b>Thermal Protection</b>								
T <sub>th(otp)</sub>	overtemperature shutdown threshold temperature	VIN = 2.8 V to 20 V	-	140	-	-	-	°C
T <sub>th(otp)hys</sub>	hysteresis of overtemperature protection threshold temperature	VIN = 2.8 V to 20 V	-	25	-	-	-	°C

13.1 Graphs



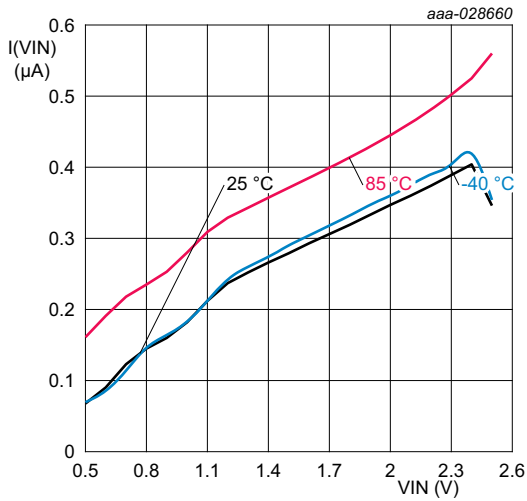
$\overline{EN} = 0V; I_O = 0 A$   
 (1)  $T_{amb} = +25\text{ }^\circ C$ .

**Fig 8. On-state quiescent current versus input voltage**



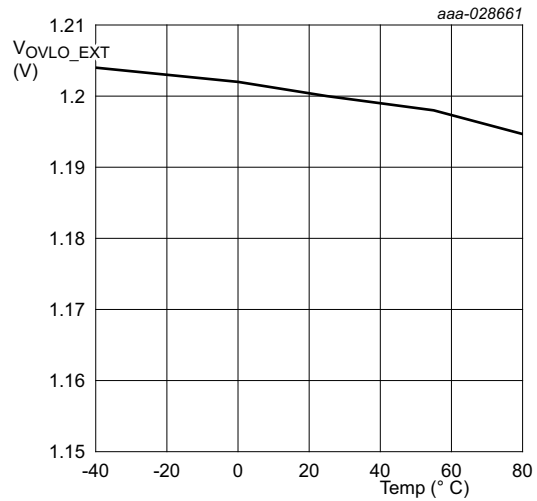
$\overline{EN} = 5V; I_O = 0 A$   
 (1)  $T_{amb} = +25\text{ }^\circ C$ .

**Fig 9. OFF-state quiescent current versus input voltage**



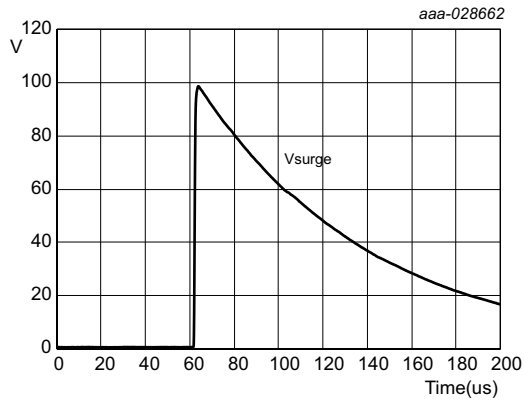
$\overline{EN} = 0V; VDD=3.0V; DETC\_EN=1$

**Fig 10. VIN pin leakage current in detection mode versus VIN voltage**



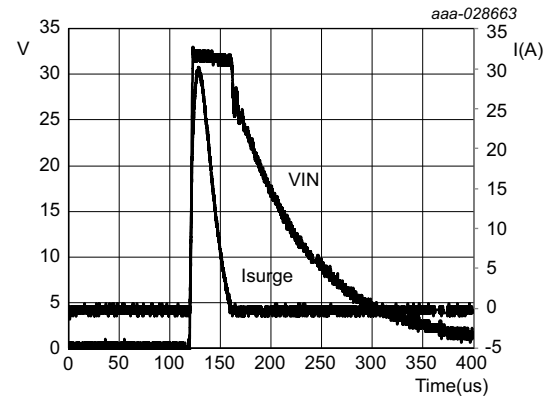
$\overline{EN} = 0V; V_{I(VIN)} = 5V;$

**Fig 11. external OVLO set threshold versus temperature**



IEC61000-4-5 100 V

Fig 12. 100 V surge voltage without device



$\overline{EN} = 0V$ ; OVLO short to GND; no capacitor on VIN

- (1)  $I_{I(VIN)}$
- (2)  $V_{I(VIN)}$
- (3)  $V_{O(VOUT)}$

Fig 13. 100 V surge with device

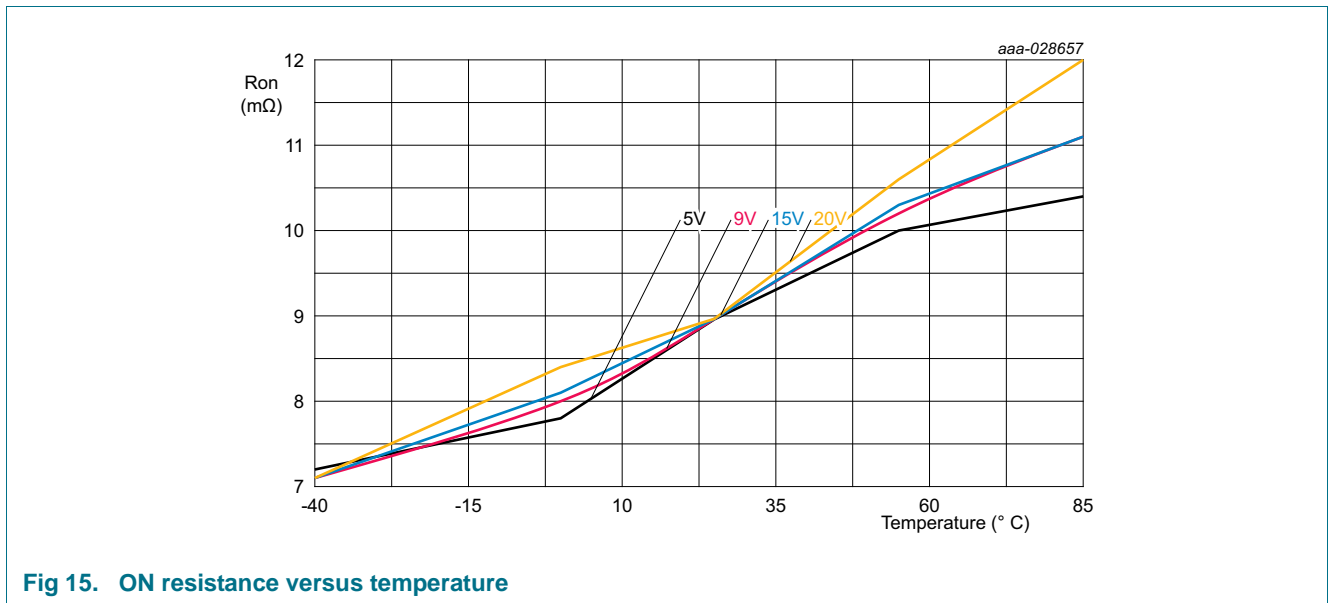
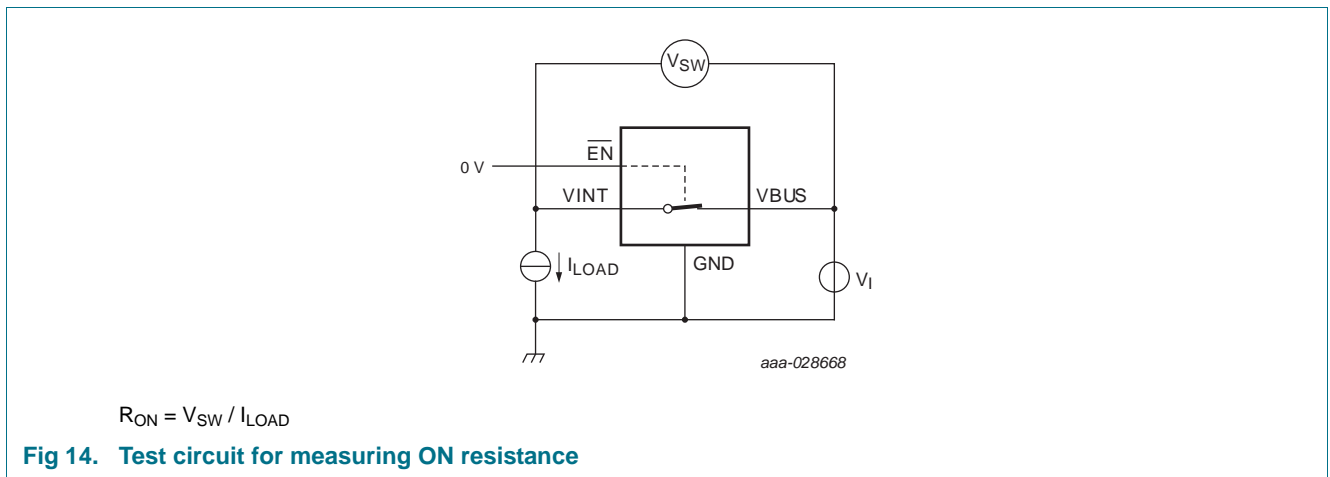
13.2 ON resistance

Table 29. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			T <sub>amb</sub> = -40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
R <sub>ON</sub>	ON resistance	I <sub>LOAD</sub> = 1 A						
		V <sub>I(VIN)</sub> = 5.0 V	-	8.95	11	-	14	mΩ
		V <sub>I(VIN)</sub> = 20 V	-	8.95	11	-	14	mΩ

13.3 ON resistance test circuit and graphs





## 14. Dynamic characteristics

**Table 30. Dynamic characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 17](#).

Symbol	Parameter	Conditions	T <sub>amb</sub> = 25 °C			T <sub>amb</sub> = -40 °C to +85 °C		Unit
			Min	Typ	Max	Min	Max	
t <sub>en</sub>	Enable Time	From $\overline{EN}$ to V <sub>(VOUT)</sub> = 10 % of V <sub>(VIN)</sub> ; (Including debounce time); V <sub>I(VIN)</sub> = 5 V; C <sub>Load</sub> = 22 μF; R <sub>Load</sub> = 100 Ω	-	23.5	-	15	30	ms
t <sub>TLH</sub>	VOUT rise time	V <sub>(VOUT)</sub> from 10 % to 90 % V <sub>(VIN)</sub> ; C <sub>Load</sub> = 22 μF; R <sub>Load</sub> = 100 Ω						
		V <sub>I(VIN)</sub> = 5 V	-	1.2	-	-	2	ms
		V <sub>I(VIN)</sub> = 20 V	-	2.5	-	-	4	ms
t <sub>dis(OVP)</sub>	OVLO turn off time	From V <sub>(VIN)</sub> > V <sub>OVLO</sub> to V <sub>(VOUT)</sub> = 80 % of V <sub>(VIN)</sub> ; R <sub>load</sub> = 100 Ω; C <sub>load</sub> = 0 μF; V <sub>I(VIN)</sub> = 20 V; ADJ pin short to GND; VIN rise >2 V/us	-	30	-	-	100	ns
t <sub>start</sub>	VIN start time	$\overline{EN}$ = 0; from VIN > V <sub>UVLO</sub> to V <sub>(VOUT)</sub> = 10 % of V <sub>(VIN)</sub>	-	23.5	-	15	30	ms
t <sub>dis</sub>	Disable time	From $\overline{EN}$ to V <sub>(VOUT)</sub> = 90 % of V <sub>(VIN)</sub> ; V <sub>I(VIN)</sub> = 5 V; C <sub>Load</sub> = 0 μF; R <sub>Load</sub> = 100 Ω	-	0.2	-	0.1	0.5	μs
t <sub>DEB</sub>	Debounce time	Time from V <sub>UVLO</sub> < VIN < V <sub>OVLO</sub> to V <sub>(VOUT)</sub> = 10 % of V <sub>(VIN)</sub>	-	23.5	-	-	-	ms
t <sub>WAKEUP</sub> <sup>[1]</sup>	Sleep to VIN detection wake up time	Time from DETC_EN = 1 to device ready for VIN impedance detection	-	1.5	3	-	3	ms
t <sub>SCP</sub>	Short circuit protection response time	VIN=5 V; Time from short circuit happened to switch turn off	-	3	-	-	-	μs
t <sub>VINDISCHARGE</sub>	Time taken for VIN discharge	VDD = 3.3 V; Load Capacitance = 10 μF VBUS pin going down below Vsafe0V after VBUS detached and switch disabled	-	-	-	-	650	ms
		VDD = 3.3 V; Load Capacitance = 10 μF VBUS pin going down below Vsafe5V (when initial voltage is >5 V) after VBUS detached and switch disabled	-	-	-	-	275	ms

[1] Guaranteed by design

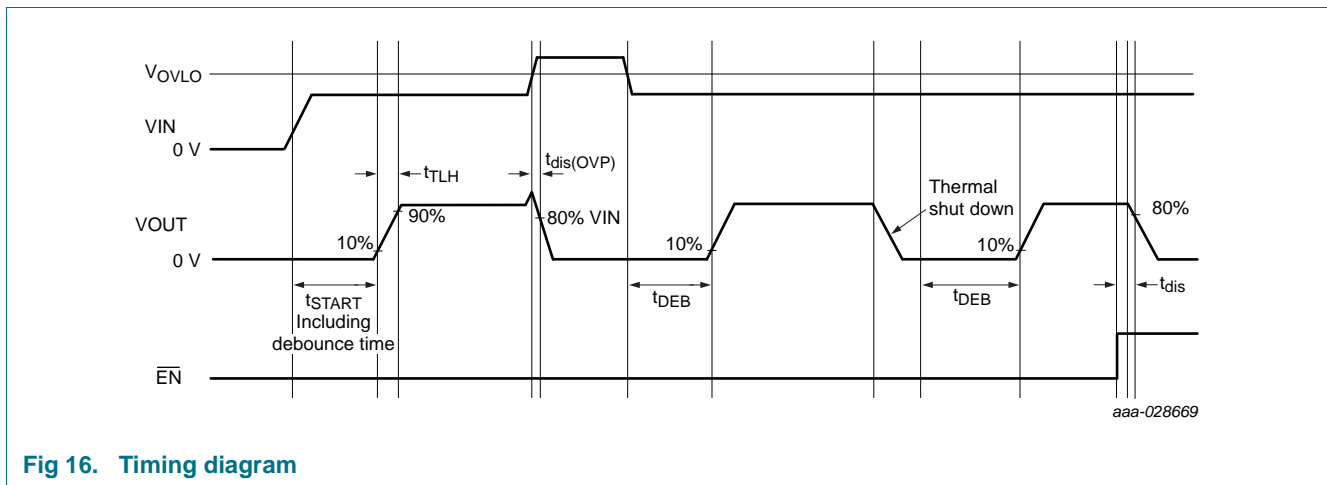
**Table 31. I<sup>2</sup>C-bus interface timing requirements**

At recommended operating conditions;  $T_{amb} = -40\text{ °C to }+85\text{ °C}$ ; voltages are referenced to GND (ground = 0 V).

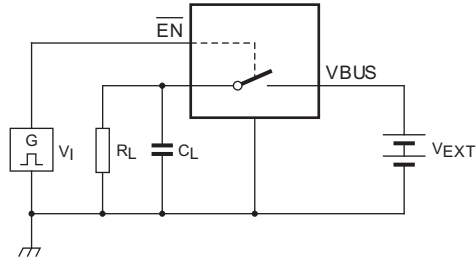
Symbol	Parameter	Conditions	Standard Mode		Fast Mode		Unit
			Min	Max	Min	Max	
f <sub>SCL</sub>	I <sup>2</sup> C SCL clock frequency		0	100	0	1000	kHz
t <sub>HIGH</sub>	HIGH period of the SCL clock		4	-	0.6	-	μs
t <sub>LOW</sub>	LOW period of the SCL clock		4.7	-	1.3	-	μs
t <sub>SP</sub>	pulse width of spikes that will be suppressed by the input filter		-	50	-	50	ns
t <sub>SU,DAT</sub>	data set-up time		250	-	100	-	ns
t <sub>r</sub>	rise time of both SDA and SCL signals		-	1000	20+0.1C <sub>b</sub> [1]	300	ns
t <sub>f</sub>	fall time of both SDA and SCL signals		-	300	20+0.1C <sub>b</sub> [1]	300	ns
t <sub>BUF</sub>	bus free time between a STOP and START condition		4.7	-	1.3	-	μs
t <sub>SU,STA</sub>	set-up time for a repeated START condition		4.7	-	0.6	-	μs
t <sub>HD,STA</sub>	hold time (repeated) START condition		4	-	0.6	-	μs
t <sub>SU,STO</sub>	set-up time for STOP condition		4	-	0.6	-	μs
t <sub>VD,DAT</sub>	data valid time	SCL LOW to SDA output valid	-	3.45	-	0.9	μs
t <sub>VD,ACK</sub>	data valid acknowledge time	ACK signal from SCL LOW to SDA LOW	-	3.45	-	0.9	μs

[1] C<sub>b</sub> = total capacitance of one bus line in pF.

### 14.1 Waveforms and test circuit



**Fig 16. Timing diagram**



aaa-028670

Test Condition is given in [Table 32](#)

R<sub>L</sub> = Load resistance.

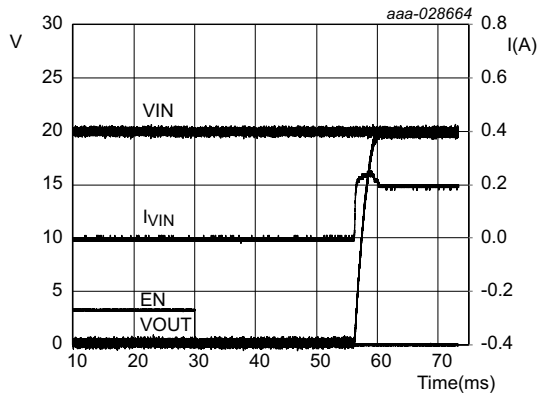
C<sub>L</sub> = Load capacitance including jig and probe capacitance.

V<sub>EXT</sub> = External voltage for measuring switching times.

**Fig 17. Test circuit for measuring switching times**

**Table 32. Test Condition**

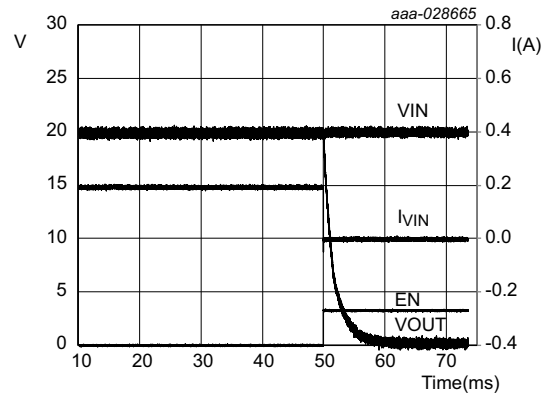
Supply voltage V <sub>EXT</sub>	Load	
VIN	C <sub>L</sub>	R <sub>L</sub>
2.8 V to 20 V	22 μF	100 Ω



V<sub>I(VIN)</sub> = 20.0 V; R<sub>L</sub> = 100 Ω; C<sub>L</sub> = 22μF

- (1) VOUT
- (2)  $\overline{\text{EN}}$
- (3) I<sub>I(VIN)</sub>

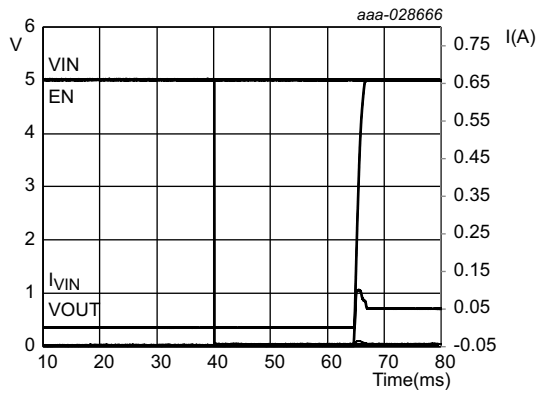
**Fig 18. Turn-on time and in-rush current at 20 V**



V<sub>I(VIN)</sub> = 20.0 V; R<sub>L</sub> = 100 Ω; C<sub>L</sub> = 22μF

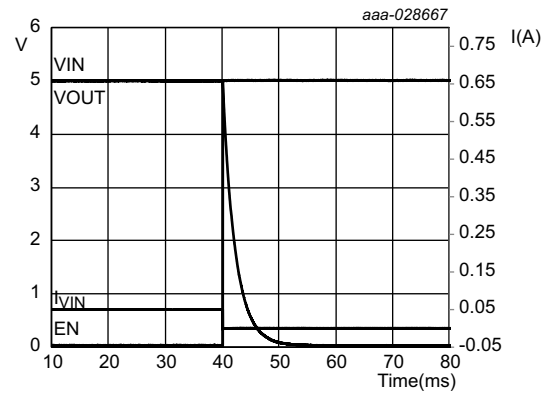
- (1) VOUT
- (2)  $\overline{\text{EN}}$
- (3) I<sub>I(VIN)</sub>

**Fig 19. Turn-off time at 20 V**



- $V_{I(VIN)} = 5\text{ V}; R_L = 100\ \Omega; C_L = 22\ \mu\text{F}$
- (1) VOUT
  - (2)  $\overline{\text{EN}}$
  - (3)  $I_{I(VIN)}$

Fig 20. Turn-on time and in-rush current at 5 V



- $V_{I(VIN)} = 5\text{ V}; R_L = 100\ \Omega; C_L = 22\ \mu\text{F}$
- (1) VOUT
  - (2)  $\overline{\text{EN}}$
  - (3)  $I_{I(VIN)}$

Fig 21. Turn-off time at 5 V

## 15. Packing information

### 15.1 SOT1397-6 (WLCSP20); Reel dry pack, SMD, 7" Q2 standard product orientation; Ordering code (12NC) ending 080

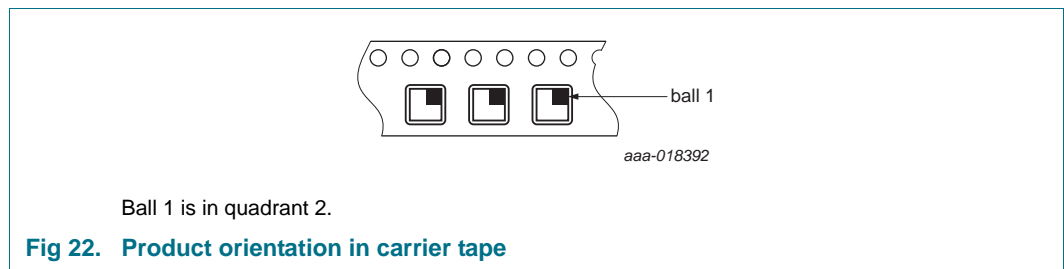
#### 15.1.1 Dimensions and quantities

Table 33. Dimensions and quantities

Reel dimensions d × w (mm) <a href="#">[1]</a>	SPQ/PQ (pcs)	Reels per box
180 × 8	4000	1

[1] d = reel diameter; w = tape width.

#### 15.1.2 Product orientation



#### 15.1.3 Carrier tape dimensions

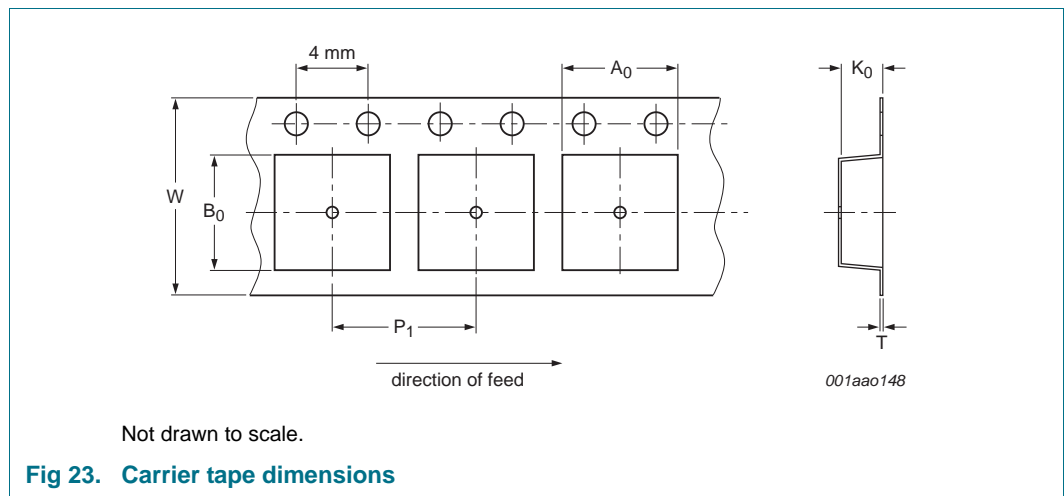
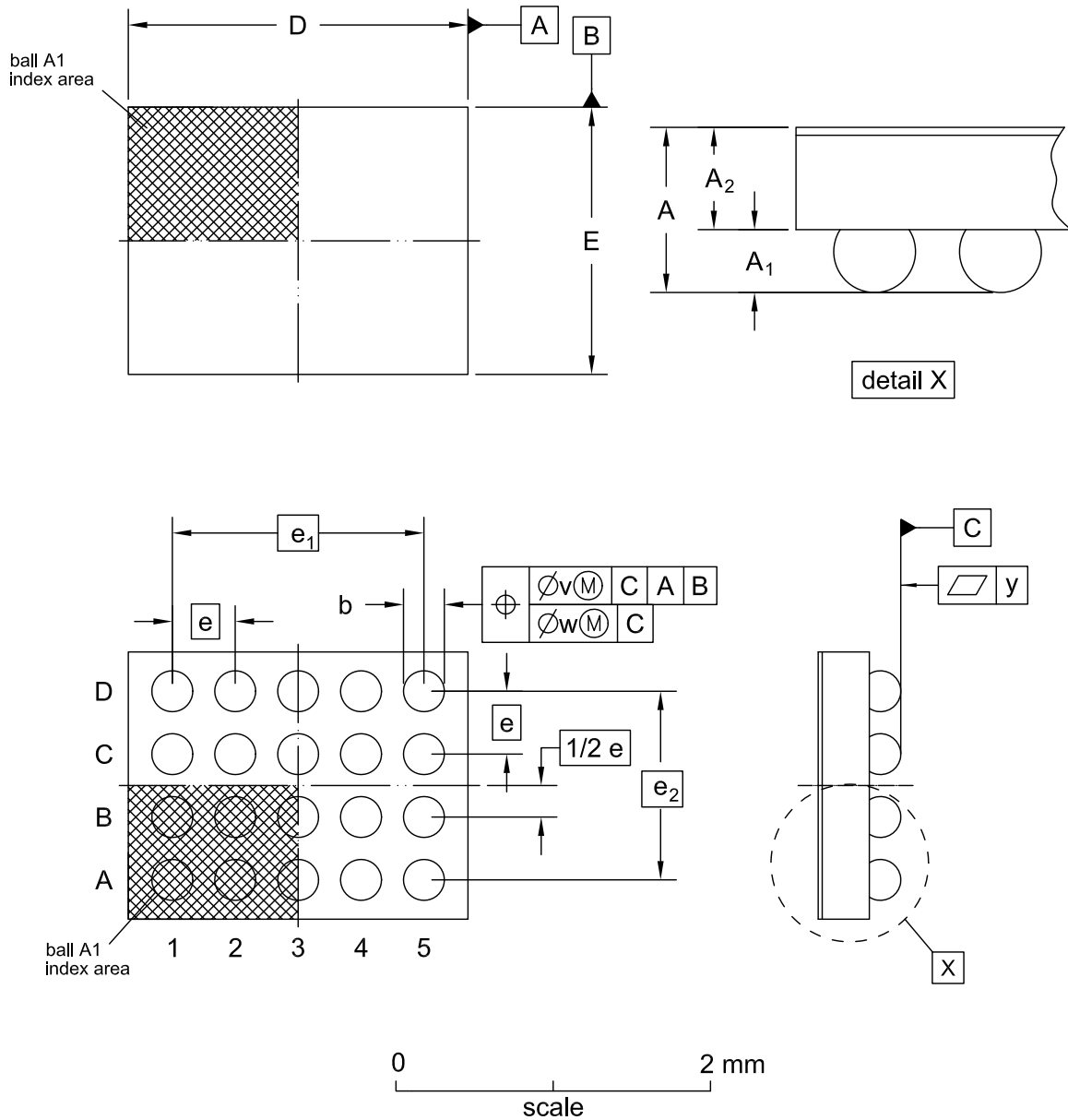


Table 34. Carrier tape dimensions

In accordance with IEC 60286-3/EIA-481.

A <sub>0</sub> (mm)	B <sub>0</sub> (mm)	K <sub>0</sub> (mm)	T (mm)	P <sub>1</sub> (mm)	W (mm)
2.00 ± 0.05	2.30 ± 0.05	0.75 ± 0.05	0.25 ± 0.03	4.0 ± 0.10	8.0 ± 0.10

16. Package outline



DIMENSIONS (mm are the original dimensions)

UNIT		A	A <sub>1</sub>	A <sub>2</sub>	b	D	E	e	e <sub>1</sub>	e <sub>2</sub>	v	w	y
mm	MAX.	0.565	0.230	0.350	0.290	2.19	1.73						
	NOM.	0.525	0.200	0.325	0.260	2.16	1.70	0.4	1.6	1.2	0.15	0.05	0.03
	MIN.	0.485	0.170	0.300	0.230	2.13	1.67						

NOTE: Backside coating 25 µm

Fig 24. Package outline SOT1397-6 (WLCSP20)

## 17. Revision history

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Document ID	Release date	Data sheet status	Change notice	Supersedes
NX30P6093 v1.1	20180918	Product data sheet	-	NX30P67093 v1.0
Modifications:	<ul style="list-style-type: none"> <li>Removed "Company confidential" status</li> <li><a href="#">Table 25 "Limiting values"</a>: <math>I_{SW}</math>, continuous switch current; changed max from 6 to 8</li> <li><a href="#">Table 26 "Recommended operating conditions"</a>: <math>V_I</math>, input voltage VIN; changed min from 0 to 2.8</li> </ul>			
NX30P6093 v1.0	20180424	Product data sheet	-	-

## 18. Legal information

### 18.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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For more information, please visit: <http://www.nxp.com>

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Date of release: 18 September 2018

Document identifier: NX30P6093